

<b>Notice of References Cited</b>	Application/Control No. 10/581,715		Applicant(s)/Patent Under Reexamination LEE, HYE-JIN	
	Examiner HONG MEHTA		Art Unit 1789	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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#### FOREIGN PATENT DOCUMENTS

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	N	JP 09084482 A	03-1997	Japan	WATANABE et al.	A01K 43/00
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